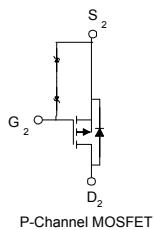
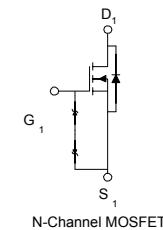
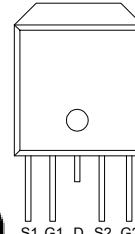


P & N-Channel 30-V (D-S) MOSFET

These miniature surface mount MOSFETs utilize a high cell density trench process to provide low $r_{DS(on)}$ and to ensure minimal power loss and heat dissipation. Typical applications are DC-DC converters and power management in portable and battery-powered products such as computers, printers, PCMCIA cards, cellular and cordless telephones.

- Low $r_{DS(on)}$ provides higher efficiency and extends battery life
- Low thermal impedance copper leadframe DPAK saves board space
- Fast switching speed
- High performance trench technology

PRODUCT SUMMARY		
V _{DS} (V)	r _{DS(on)} m(Ω)	I _D (A)
30	45 @ V _{GS} = 4.5V	29
	35 @ V _{GS} = 10V	36
-30	70 @ V _{GS} = -4.5V	-20
	52 @ V _{GS} = -10V	-26



ESD Protected
2000V

ABSOLUTE MAXIMUM RATINGS (T_A = 25 °C UNLESS OTHERWISE NOTED)

Parameter	Symbol	N-Channel	P-Channel	Units
Drain-Source Voltage	V _{DS}	30	-30	V
Gate-Source Voltage	V _{GS}	±20	±20	
Continuous Drain Current ^a	I _D	36	-26	A
		30	-21	
Pulsed Drain Current ^b	I _{DM}	40	-40	
Continuous Source Current (Diode Conduction) ^a	I _S	30	-30	A
Power Dissipation ^a	P _D	50	50	W
Operating Junction and Storage Temperature Range	T _J , T _{stg}	-55 to 175		°C

THERMAL RESISTANCE RATINGS

Parameter	Symbol	Maximum	Units
Maximum Junction-to-Ambient ^a	R _{θJA}	50	°C/W
Maximum Junction-to-Case	R _{θJC}	3.0	°C/W

Notes

- Surface Mounted on 1" x 1" FR4 Board.
- Pulse width limited by maximum junction temperature

SPECIFICATIONS ($T_A = 25^\circ\text{C}$ UNLESS OTHERWISE NOTED)						
Parameter	Symbol	Test Conditions	Limits			Unit
			Ch	Min	Typ	
Static						
Gate-Threshold Voltage	$V_{GS(\text{th})}$	$V_{GS} = V_{DS}, I_D = 250 \mu\text{A}$	N	0.6		V
		$V_{GS} = V_{DS}, I_D = -250 \mu\text{A}$	P	-0.6		
Gate-Body Leakage	I_{GSS}	$V_{GS} = -20 \text{ V}, V_{DS} = 0 \text{ V}$	P		± 100	nA
		$V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$	N		± 100	
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = -24 \text{ V}, V_{GS} = 0 \text{ V}$	P		-1	uA
		$V_{DS} = 24 \text{ V}, V_{GS} = 0 \text{ V}$	N		1	
On-State Drain Current ^a	$I_{D(\text{on})}$	$V_{DS} = 5 \text{ V}, V_{GS} = 10 \text{ V}$	N	20		A
		$V_{DS} = -5 \text{ V}, V_{GS} = -10 \text{ V}$	P	-20		
Drain-Source On-Resistance ^a	$r_{DS(on)}$	$V_{GS} = 10 \text{ V}, I_D = 6.9 \text{ A}$	N		35	mΩ
		$V_{GS} = 4.5 \text{ V}, I_D = 6 \text{ A}$	N		45	
		$V_{GS} = -10 \text{ V}, I_D = -5.2 \text{ A}$	P		52	
		$V_{GS} = -4.5 \text{ V}, I_D = -4.2 \text{ A}$	P		70	
Forward Transconductance ^a	g_s	$V_{DS} = 15 \text{ V}, I_D = 6.9 \text{ A}$	N		25	S
		$V_{DS} = -15 \text{ V}, I_D = -5.2 \text{ A}$	P		10	
Dynamic						
Total Gate Charge	Q_g	N-Channel $V_{DS}=15\text{V}, V_{GS}=10\text{V}, I_D=6.9\text{A}$ P-Channel $V_{DS}=-15\text{V}, V_{GS}=-10\text{V}, I_D=-5.2\text{A}$	N		6.0	nC
Gate-Source Charge	Q_{gs}		P		10	
Gate-Drain Charge	Q_{gd}		N		1.0	
Turn-On Delay Time	$t_{d(\text{on})}$		P		2.4	
Rise Time	t_r		N		1.5	
Turn-Off Delay Time	$t_{d(\text{off})}$		P		3.9	
Fall-Time	t_f	N-Channel $V_{DD}=15\text{V}, V_{GS}=10\text{V}, I_D=1\text{A}$, $R_{GEN}=6\Omega$ P-Channel $V_{DD}=15\text{V}, V_{GS}=-10\text{V}, I_D=-1\text{A}$, $R_{GEN}=6\Omega$	N		7.4	nS
			P		7.6	
			N		4	
			P		6.8	
			N		22.2	
			P		33.6	
			N		3.6	
			P		23.2	

Notes

- a. Pulse test: PW <= 300us duty cycle <= 2%.
- b. Guaranteed by design, not subject to production testing.

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Typical Electrical Characteristics (N-Channel)

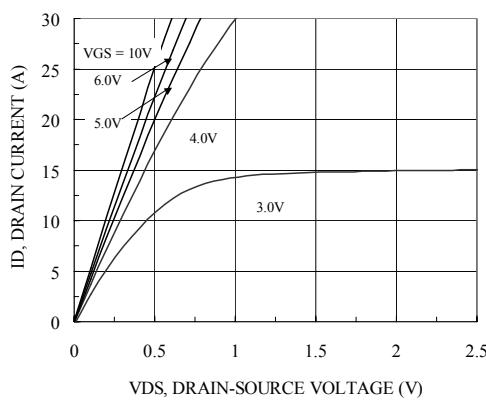


Figure 1. On-Region Characteristics

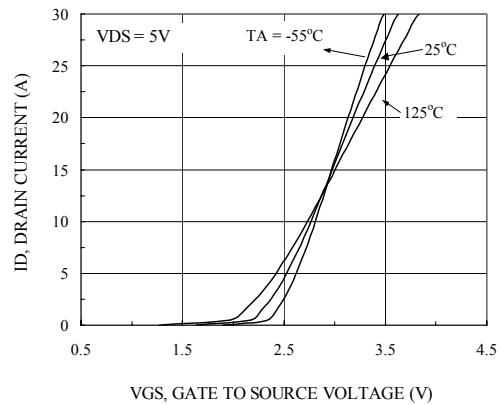


Figure 2. Body Diode Forward Voltage Variation with Source Current and Temperature

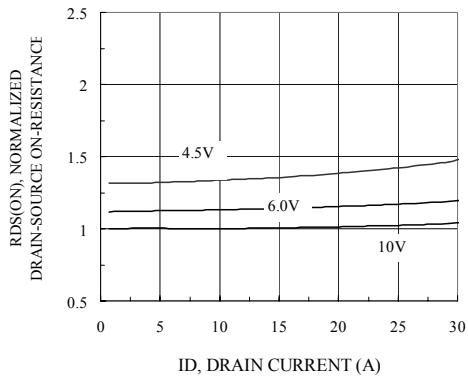


Figure 3. On Resistance Vs Vgs Voltage

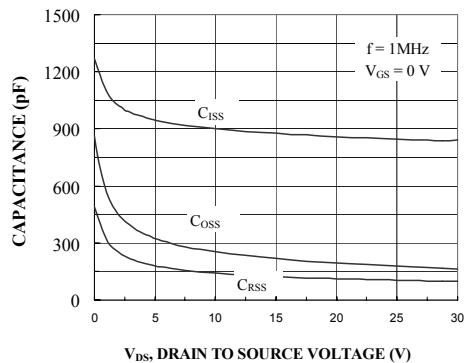


Figure 4. Capacitance Characteristics

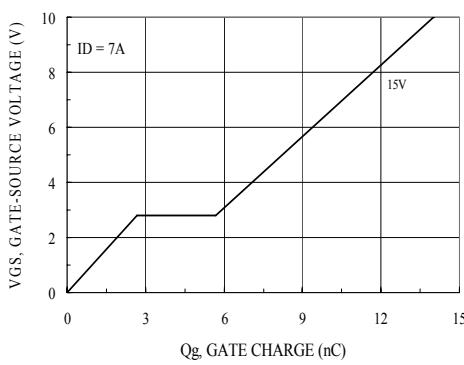


Figure 5. Gate Charge Characteristics

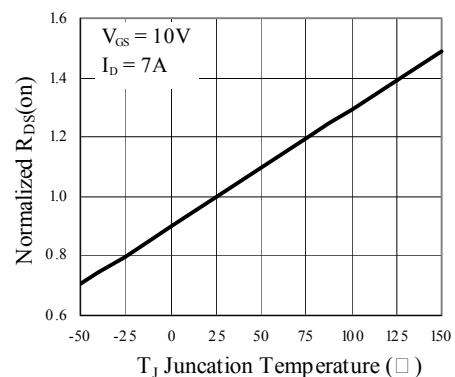


Figure 6. On-Resistance Variation with Temperature

Typical Electrical Characteristics (N-Channel)

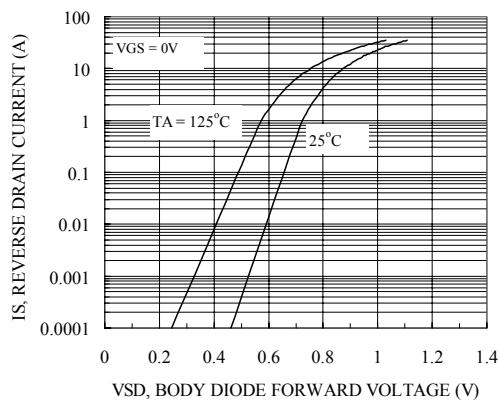


Figure 7. Transfer Characteristics

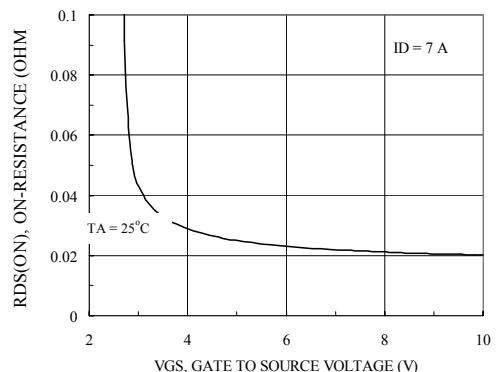


Figure 8. On-Resistance with Gate to Source Voltage

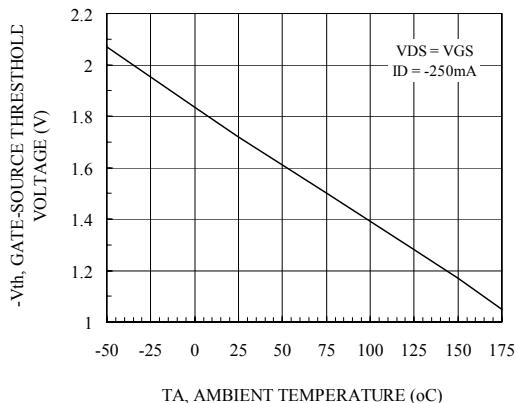


Figure 9. Vth Gate to Source Voltage Vs Temperature

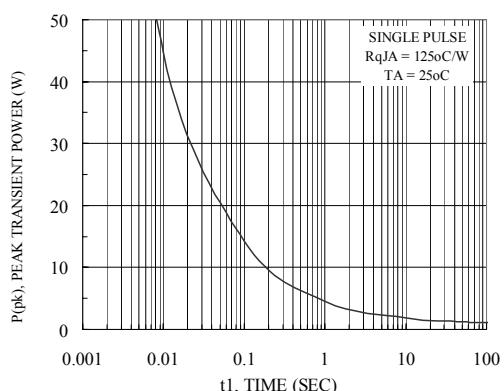


Figure 10. Single Pulse Maximum Power Dissipation

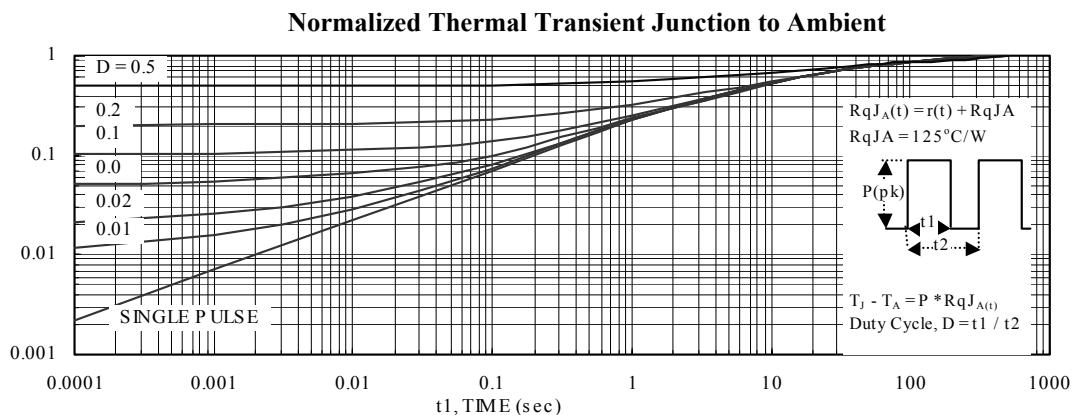


Figure 11. Transient Thermal Response Curve

Typical Electrical Characteristics (P-Channel)

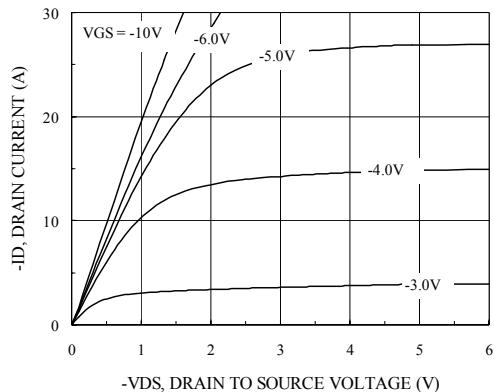


Figure 1. On-Region Characteristics

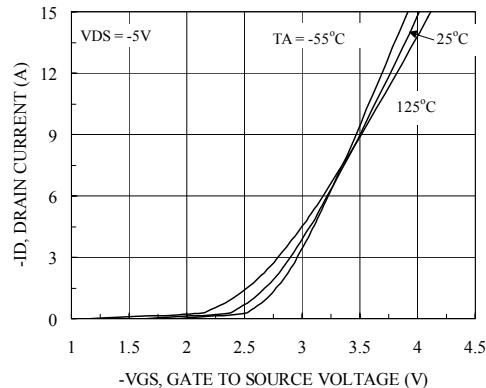


Figure 2. Body Diode Forward Voltage Variation with Source Current and Temperature

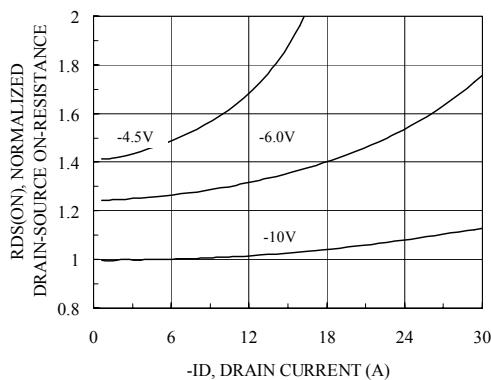


Figure 3. On Resistance Vs Vgs Voltage

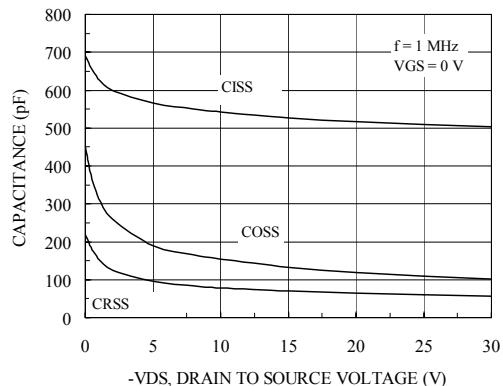


Figure 4. Capacitance Characteristics

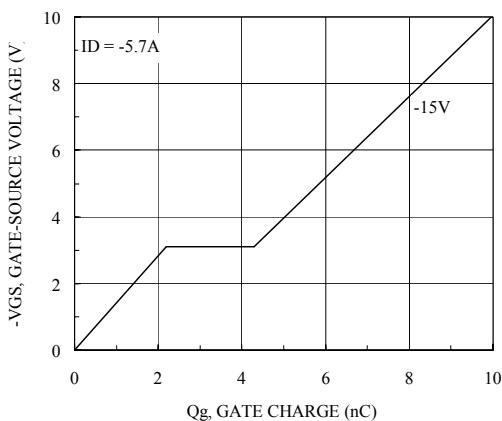


Figure 5. Gate Charge Characteristics

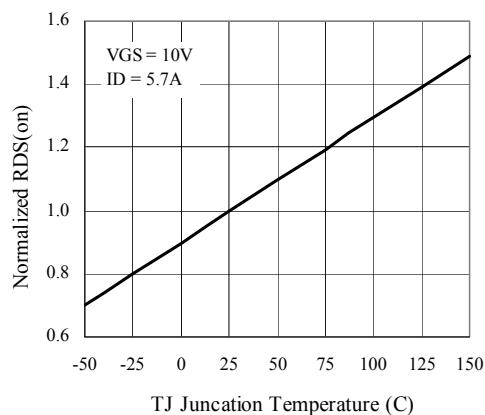


Figure 6. On-Resistance Variation with Temperature

Typical Electrical Characteristics (P-Channel)

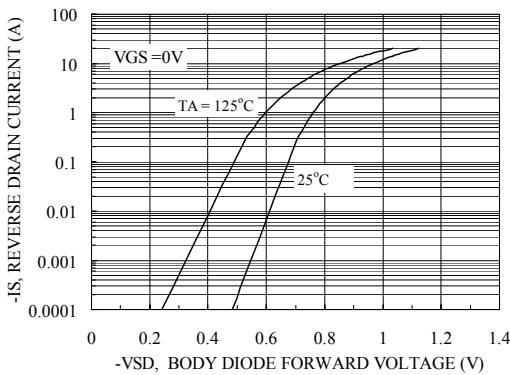


Figure 7. Transfer Characteristics

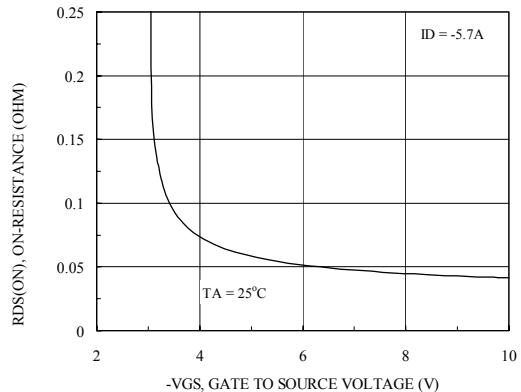


Figure 8. On-Resistance with Gate to Source Voltage

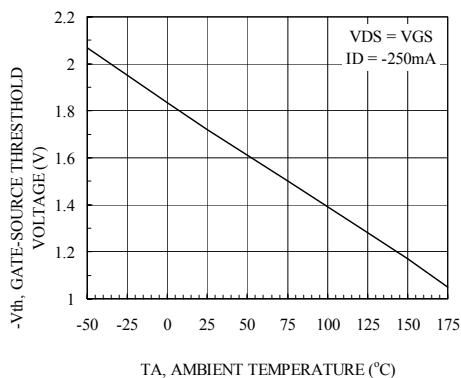


Figure 9. Vth Gate to Source Voltage Vs Temperature

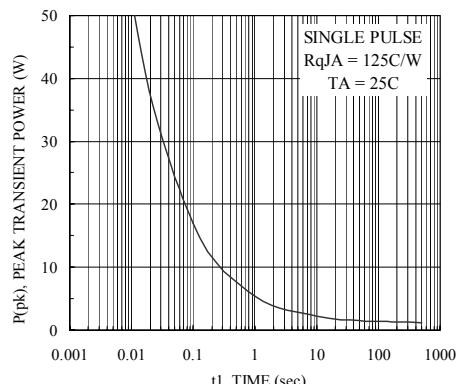


Figure 10. Single Pulse Maximum Power Dissipation

Normalized Thermal Transient Junction to Ambient

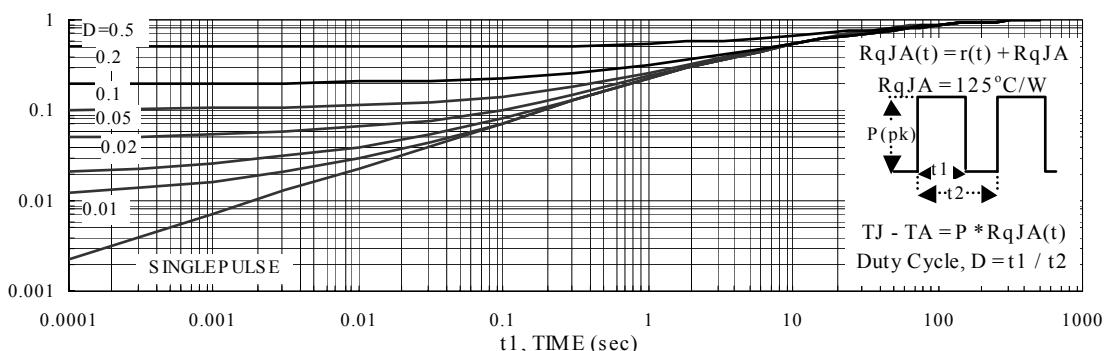
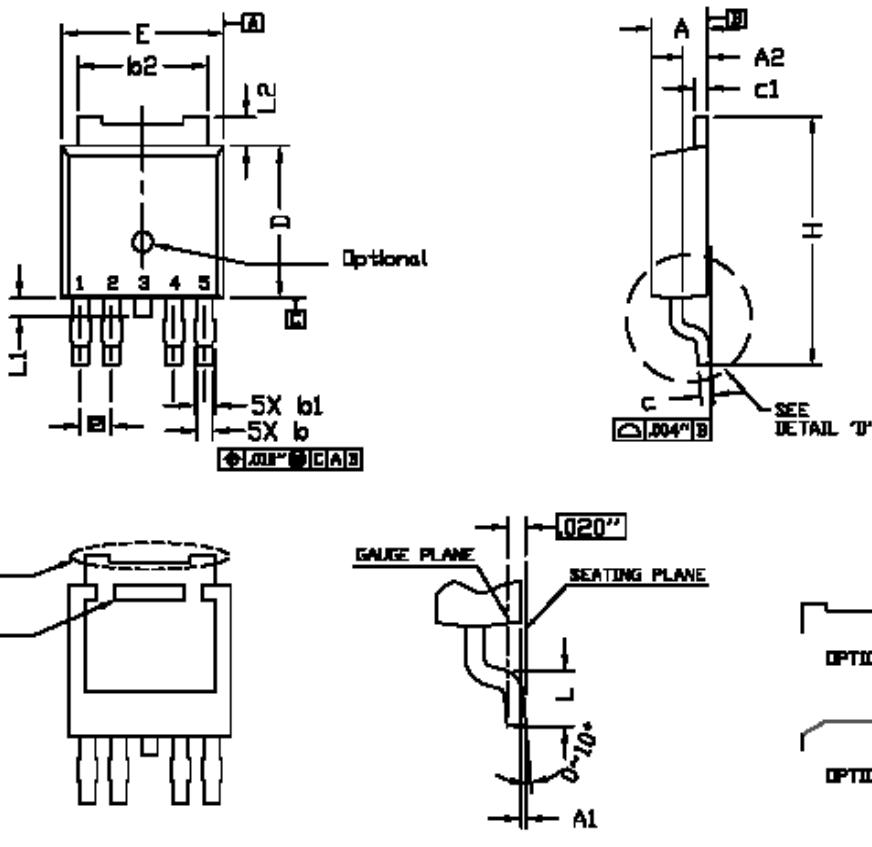


Figure 11. Transient Thermal Response Curve

TO252_4L PACKAGE OUTLINE



NOTE

1. PACKAGE BODY SIZES EXCLUDE MOLD FLASH AND GATE BURRS. MOLD FLASH SHOULD BE LESS THAN 6 MIL.
2. DIMENSION L IS MEASURED IN GAUGE PLANE.
3. TOLERANCE 0.10 mm UNLESS OTHERWISE SPECIFIED.
4. CONTROLLING DIMENSION IS MILLIMETER. CONVERTED INCH DIMENSIONS ARE NOT NECESSARILY EXACT.
5. REFER TO JEDEC TO-252 (AD).

SYMBOL	DIMENSION IN MILLIMETERS			DIMENSIONS IN INCHES		
	MIN.	NOM.	MAX.	MIN.	NOM.	MAX.
A	2.184	2.288	2.388	0.086	0.090	0.094
A1	0.000	—	0.127	0.000	—	0.005
A2	0.889	—	1.143	0.035	—	0.045
b	0.508	—	0.711	0.020	—	0.028
b1	0.584	—	0.787	0.023	—	0.031
b2	4.953	—	5.461	0.195	—	0.215
c	0.457	0.508	0.610	0.018	0.020	0.024
c1	0.457	—	0.610	0.018	—	0.024
D	5.989	6.098	6.223	0.235	0.240	0.245
E	6.350	6.804	6.731	0.250	0.260	0.265
e	1.270 BSC.			0.060 BSC.		
H	9.398	—	10.414	0.370	—	0.410
L	1.270	—	2.032	0.050	—	0.080
L1	—	—	1.016	—	—	0.040
L2	0.889	—	1.270	0.035	—	0.050